

## LMNP2093EX7F N & P Pair Enhancement Mode MOSFET

### Features

- N-Channel
- 20V/0.5A,  $R_{DS(ON)}=450\text{m}\Omega$ @ $V_{GS}=4.5\text{V}$
- 20V/0.4A,  $R_{DS(ON)}=600\text{m}\Omega$ @ $V_{GS}=2.5\text{V}$
- 20V/0.2A,  $R_{DS(ON)}=750\text{m}\Omega$ @ $V_{GS}=1.8\text{V}$
- P-Channel
- -20V/-0.5A,  $R_{DS(ON)}=800\text{m}\Omega$ @ $V_{GS}=-4.5\text{V}$
- -20V/-0.2A,  $R_{DS(ON)}=1050\text{m}\Omega$ @ $V_{GS}=-2.5\text{V}$
- -20V/-0.1A,  $R_{DS(ON)}=1500\text{m}\Omega$ @ $V_{GS}=-1.8\text{V}$
- Low-Voltage Operation
- High-Speed Circuits
- Low Battery Voltage Operation
- SOT-563 package design

### Product Description

LMNP2093E is the N and P Pair enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent  $R_{DS(ON)}$ , low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer and other battery powered circuits, and low in-line power loss are needed in commercial industrial surface mount applications.

### Applications

- Load Switch for Portable Devices, Smart Phones, Pagers.

### Pin Configuration

LMNP2093EX7F (SOT-563)		
D1	G2	S2
6	5	4
1	2	3
S1	G1	D2
Pin	Description	
1	Source 1	
2	Gate 1	
3	Drain 2	
4	Source 2	
5	Gate 2	
6	Drain 1	

**n-channel**                    **p-channel**

**Ordering Information**

Ordering Information				
Part Number	P/N	PKG code	Pb Free code	Package
LMNP2093EX6F	LMNP2093E	X7	F	SOT-563

**Marking Information**

Marking Information	
Part Number	LFC code
<u>9</u>	<u>XM</u>

**Absolute Maximum Ratings**
(T<sub>C</sub>=25°C Unless otherwise noted)

<b>Symbol</b>	<b>Parameter</b>	<b>Typical</b>		<b>Unit</b>
		N-Channel	P-Channel	
V <sub>DSS</sub>	Drain-Source Voltage	20	-20	V
V <sub>GSS</sub>	Gate-Source Voltage	±10	±8	V
I <sub>D</sub>	Continuous Drain Current (T <sub>J</sub> =150°C) <sup>1</sup>	T <sub>A</sub> =25°C <sup>1</sup>	0.59	-0.45
		T <sub>A</sub> =70°C	0.48	-0.36
I <sub>DM</sub>	Pulsed Drain Current	1.7	-1.3	A
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> =25°C	0.28	W
		T <sub>A</sub> =70°C	0.18	W/°C
T <sub>J</sub>	Operating Junction Temperature	-55/150		°C
T <sub>STG</sub>	Storage Temperature Range	-55/150		°C
R <sub>θJA</sub>	Thermal Resistance-Junction to Case	450		°C/W

Note:

1. Device mounted on FR-4 substrate PC board.

**Electrical Characteristics(N-Channel)**
(T<sub>C</sub>=25°C Unless otherwise noted)

Symbol	Parameter	Conditions			Min	Typ	Max	Unit	
<b>Static characteristics</b>									
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	N-Ch	20				V	
		V <sub>GS</sub> =0V, I <sub>D</sub> =-250uA	P-Ch	-20					
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	N-Ch	0.3		1.0			
		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250uA	P-Ch	-0.3		-1.0			
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±10V	N-Ch			±10		uA	
		V <sub>DS</sub> =0V, V <sub>GS</sub> =±8V	P-Ch			±10			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =16V, V <sub>GS</sub> =0V	N-Ch			1		uA	
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V	P-Ch			-1			
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =0.15A	N-Ch			1.3		V	
		V <sub>GS</sub> =0V, I <sub>S</sub> =-0.15A	P-Ch			-1.3			
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.5A	N-Ch	230	450			mΩ	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.5A	P-Ch	615	800				
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =0.4A	N-Ch	300	600				
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-0.2A	P-Ch	815	1050				
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =0.2A	N-Ch	400	750				
		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-0.1A	P-Ch	1050	1500				
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =0.4A	N-Ch		0.9			S	
		V <sub>DS</sub> =-10V, I <sub>D</sub> =-0.4A	P-Ch		1.1				
<b>Dynamic characteristics</b>									
Q <sub>g</sub>	Total Gate Charge <sup>1,2</sup>	N-Channel V <sub>DS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.25A P-Channel V <sub>DS</sub> =-10V, V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.25A	N-Ch		0.74			nC	
			P-Ch		0.63				
Q <sub>gs</sub>	Gate-Source Charge <sup>1,2</sup>		N-Ch		0.1				
			P-Ch		0.11				
Q <sub>gd</sub>	Gate-Drain Charge <sup>1,2</sup>		N-Ch		0.12				
			P-Ch		0.13				
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1.0MHz	N-Ch		60.7			pF	
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V, f=1.0MHz	P-Ch		59.8				
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1.0MHz	N-Ch		10				
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V, f=1.0MHz	P-Ch		12.1				
C <sub>rss</sub>	Reverse Transfer Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1.0MHz	N-Ch		5.37				
		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V, f=1.0MHz	P-Ch		6.4				
t <sub>d(on)</sub>	Turn-On Time	N-Channel VDD=10V, RL=47Ω, ID=0.2A VGEN=4.5V, RG=10Ω P-Channel VDD=-10V, RL=47Ω, ID=-0.2A VGEN=-4.5V, RG=10Ω	N-Ch		5.1			ns	
			P-Ch		5.1				
t <sub>r</sub>	Turn-Off Time		N-Ch		7.4				
			P-Ch		8.1				
t <sub>d(off)</sub>	Turn-Off Time		N-Ch		27				
			P-Ch		29				
t <sub>f</sub>	Turn-Off Time		N-Ch		13				
			P-Ch		21				

### Typical Performance Characteristics(N-Channel)

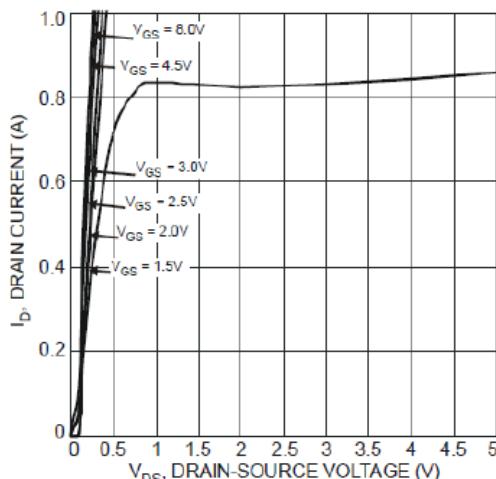


Fig. 1 Typical Output Characteristics

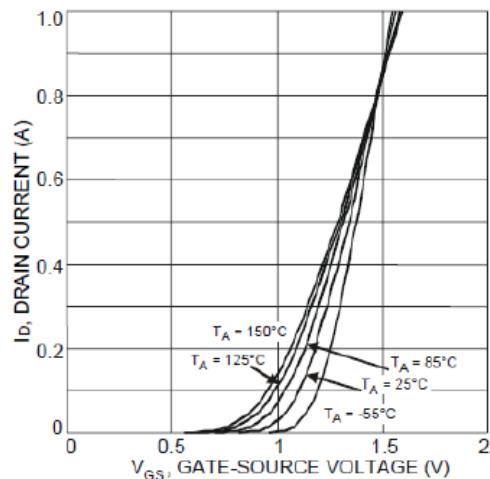


Fig. 2 Typical Transfer Characteristics

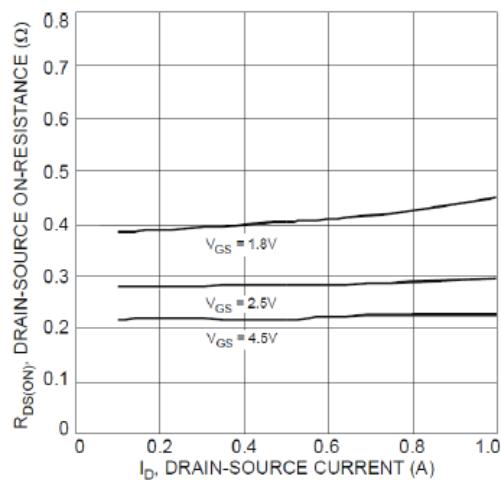


Fig. 3 Typical On-Resistance vs.  $I_D$  and  $V_{GS}$

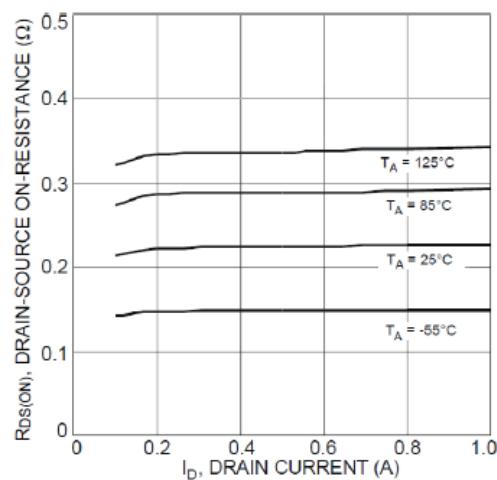


Fig. 4 Typical Drain-Source On-Resistance vs.  $I_D$  and  $T_A$

### Typical Performance Characteristics (N-Channel Continue)

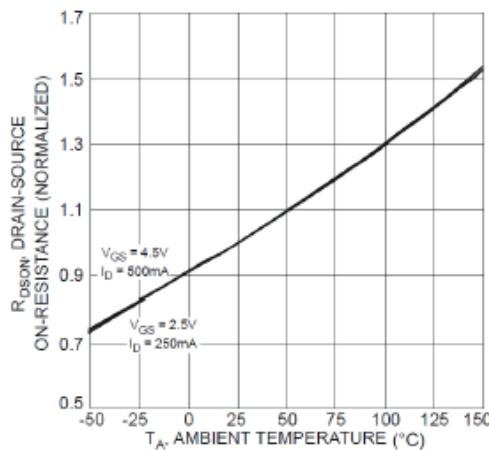


Fig. 5 On-Resistance Variation with  $T_A$

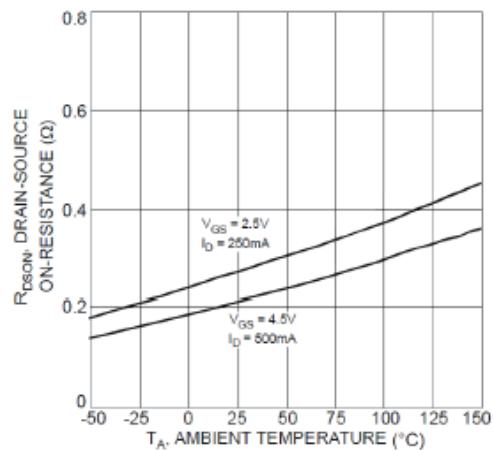


Fig. 6 On-Resistance Variation with  $T_A$

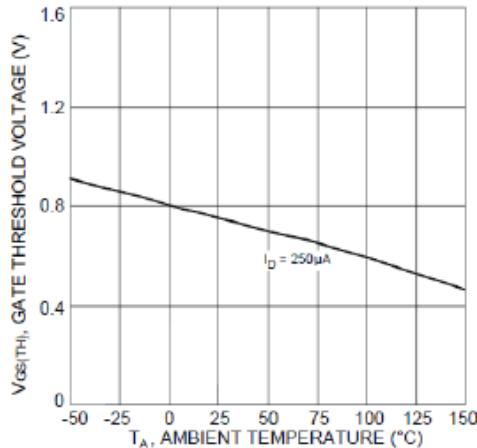


Fig. 7 Gate Threshold Variation vs.  $T_A$

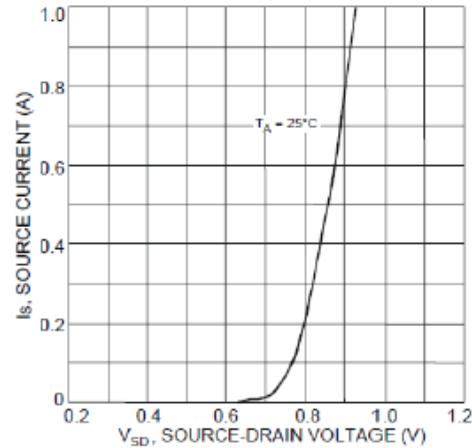


Fig. 8 Diode Forward Voltage vs. Current

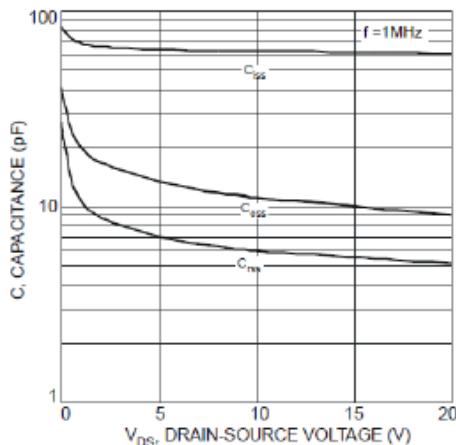
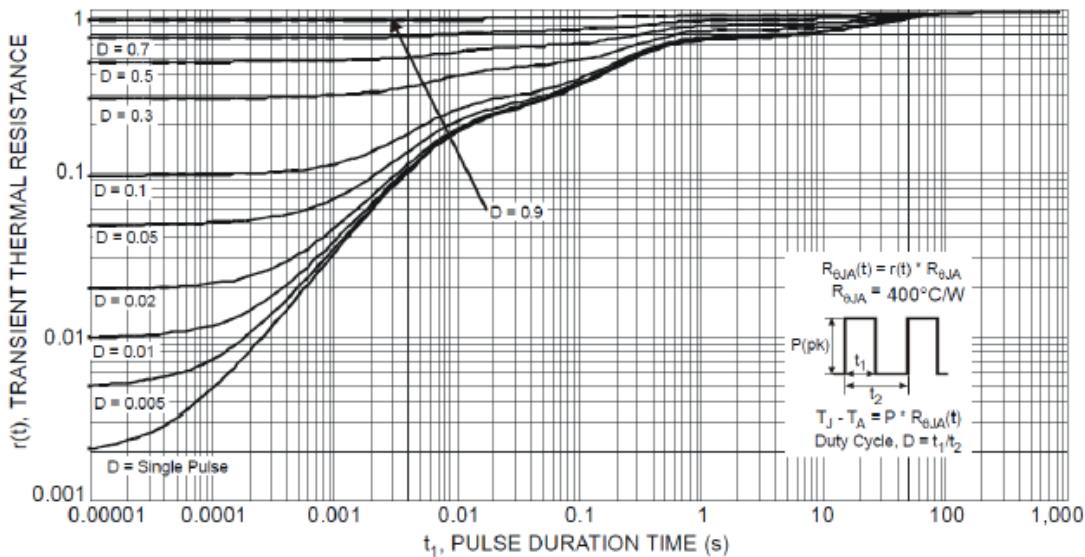


Fig. 9 Typical Capacitance

**Typical Performance Characteristics (N-Channel Continue)**

**Fig. 10 Transient Thermal Response**

### Typical Performance Characteristics(P-Channel)

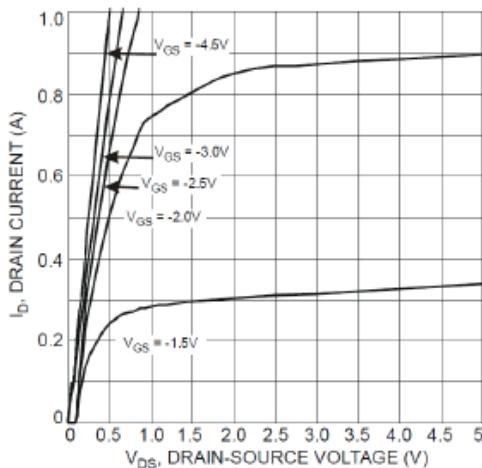


Fig. 1 Typical Output Characteristics

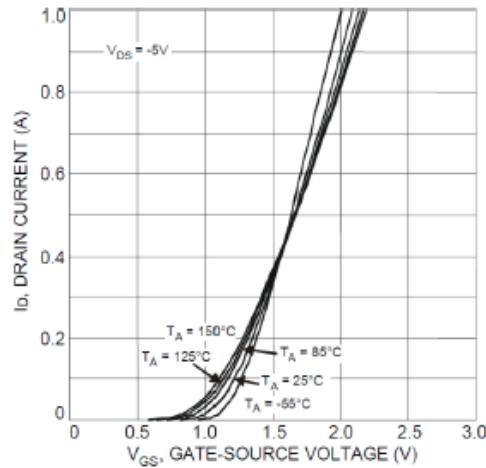


Fig. 2 Typical Transfer Characteristics

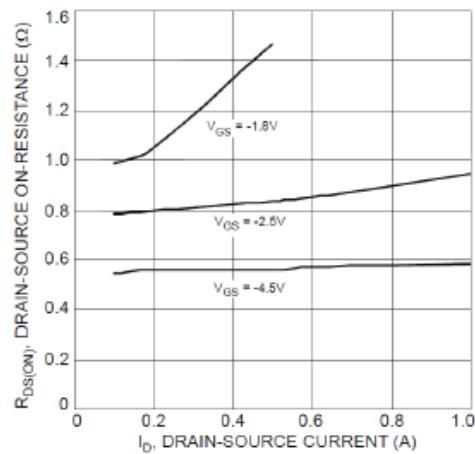


Fig. 3 Typical On-Resistance vs.  $I_D$  and  $V_{GS}$

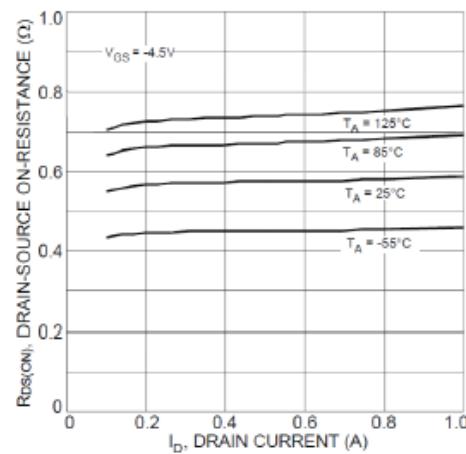


Fig. 4 Typical Drain-Source On-Resistance vs.  $I_D$  and  $T_A$

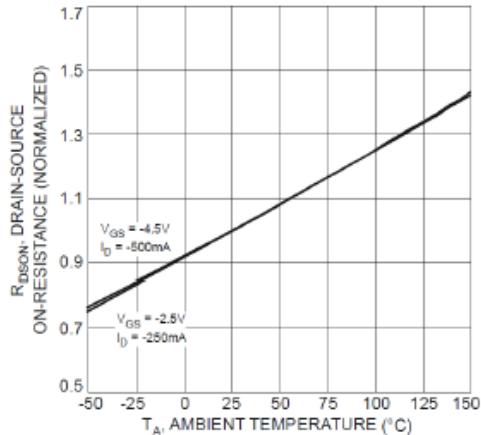


Fig. 5 On-Resistance Variation with  $T_J$

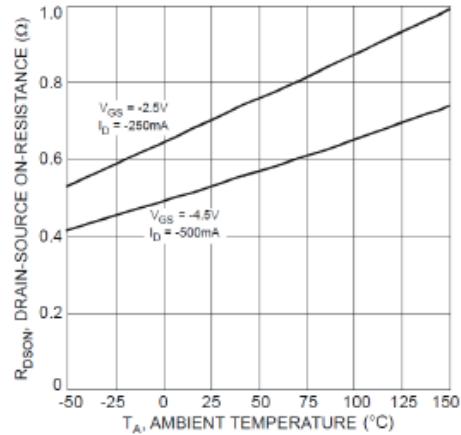
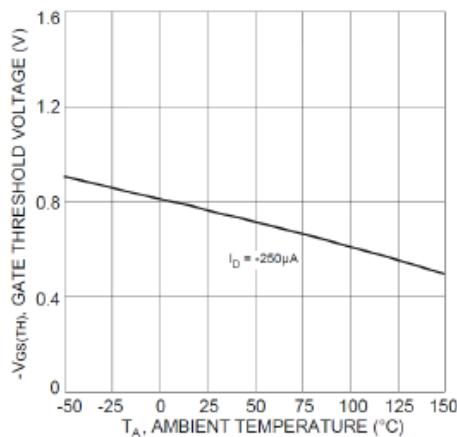
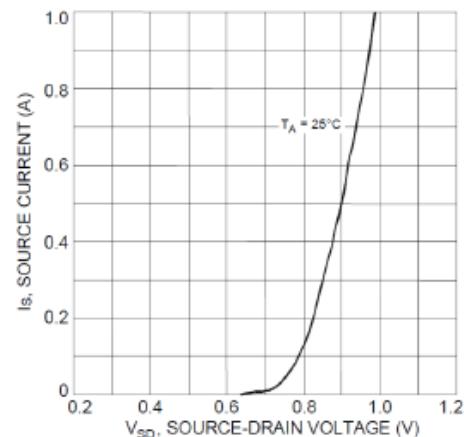
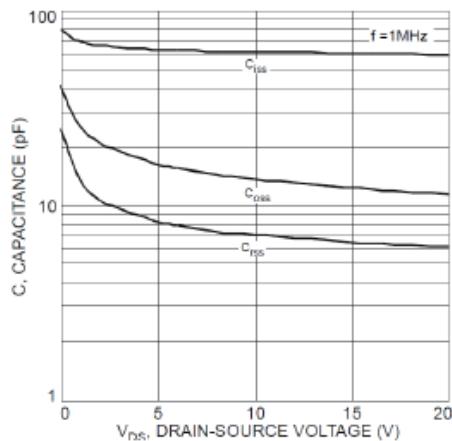
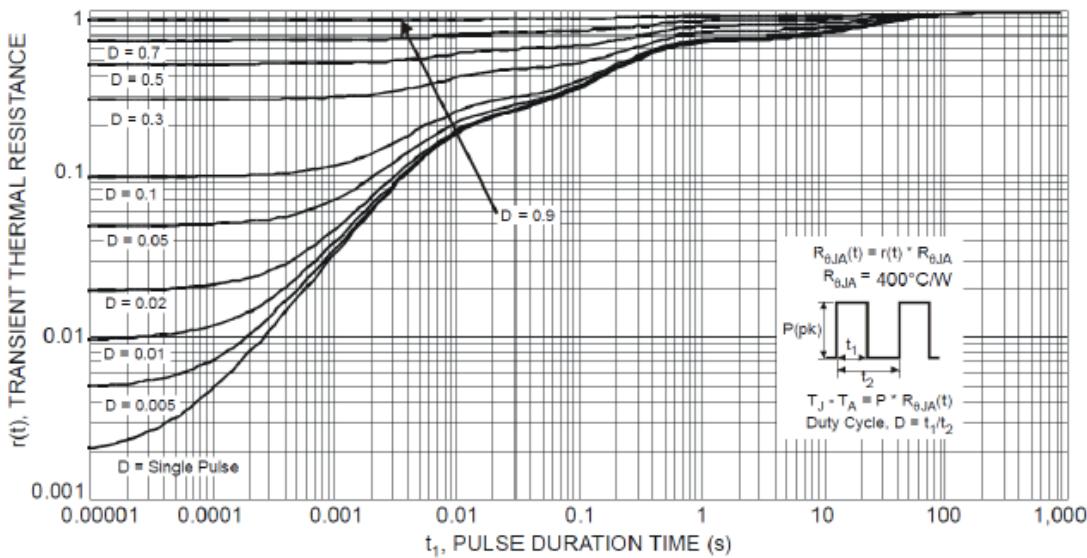
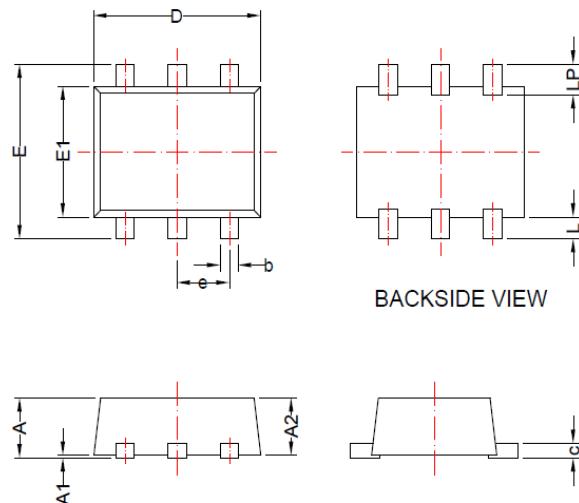


Fig. 6 On-Resistance Variation with  $T_J$

**Typical Performance Characteristics (P-Channel Continue)**

**Fig. 7 Gate Threshold Variation vs.  $T_A$** 

**Fig. 8 Diode Forward Voltage vs. Current**

**Fig. 9 Typical Capacitance**

**Fig. 10 Transient Thermal Response**

**Package Dimension:**
**SOT-563**


DIMENSION D AND E1 DO NOT INCLUDE MOLD FLASH,TIE BAR BURRS , GATE BURRS , AND INTERLEAD FLASH,NOT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY

<b>Symbol</b>	<b>Dimensions</b>			
	<b>Millimeters</b>		<b>Inches</b>	
	<b>Min</b>	<b>Max</b>	<b>Min</b>	<b>Max</b>
<b>A</b>	0.45	0.65	0.018	0.026
<b>A1</b>	0.00	0.10	0.000	0.004
<b>A2</b>	0.45	0.60	0.018	0.024
<b>b</b>	0.15	0.30	0.006	0.012
<b>c</b>	0.07	0.20	0.003	0.008
<b>D</b>	1.50	1.70	0.059	0.067
<b>E</b>	1.50	1.70	0.059	0.067
<b>E1</b>	1.10	1.30	0.043	0.051
<b>e</b>	0.50 BSC		0.020 BSC	
<b>L</b>	0.10	0.30	0.004	0.012
<b>LP</b>	0.16	0.4	0.006	0.016

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